

Form PTO-1449		ATTORNEY DOCKET NO.	SERIAL NO.
PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of <u>1</u>		11-219	10/765, 882
		APPLICANT	Jun OONISHI
		FILING DATE	GROUP
		1/29/04	

U.S.PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date

FOREIGN PATENT DOCUMENTS						English Abstract	
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Yes	No
EO	ED	2003-28890	1/29/03	Japan	—	X	—

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	

EXAMINER:		Date Considered:	8/18/05
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	ATTY. DKT NO. 11-219	SER. NO. 10/765,882
APPLICANT OONISHI		
FILING DATE January 29, 2004		GROUP 2632

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
ED	—	5,633,461	02/27/97	Kakizaki et al.		

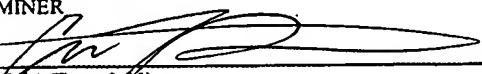
FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
									Eng. Abstract
ES	1	WO 92/20096	11/12/92	PCT				X	
EP	1	EP 0 261 555	03/30/88	Europe				X	
		DE 195 03 778	08/08/96	Germany					X

- Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER 	DATE CONSIDERED 8/18/05	
Rev. 10/94 (Form 385)		